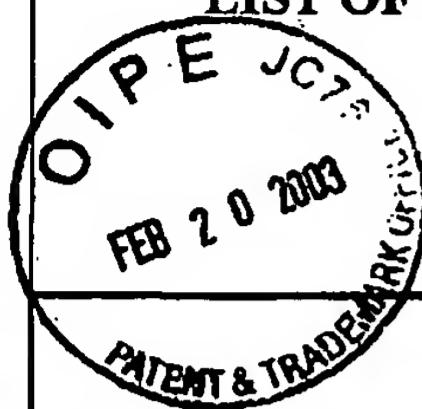


<p style="text-align: center;">LIST OF REFERENCES CITED BY APPLICANT <small>(Use several sheets if necessary)</small></p> <p>NOV 04 2002</p> <p style="text-align: right;">U.S. PATENT DOCUMENTS</p>				ATTY. DOCKET NO.	APPLICATION NO.		
				618-1018	10/085,100		
				APPLICANT			
				Enric AMOROS et al.			
				FILING DATE	GROUP		
				March 1, 2002	3743		
EXAMINER INITIAL <i>MM</i>	DOCUMENT NUMBER	DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA US 2002/0136996	9/26/02	Ichikawa et al.		431	153	
	AB 6,106,277	8/22/00	Xie		431	153	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
<i>MM</i>	DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION
	AJ JP 2002-54814	2/20/02	Japan w/Eng. Abstract		<u> </u>	<u> </u>	YES NO
	AK JP 2001-343122	12/14/01	Japan w/Eng. Abstract		<u> </u>	<u> </u>	
	AL						
	AM						
	AN						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
AO							
AP							
AQ							
EXAMINER	<i>MARK U. BUDD</i>			DATE CONSIDERED		<i>4-21-04</i>	
PRIMARY EXAMINER							
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

LIST OF REFERENCES CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				ATTY DOCKET NO. 618-1018	APPLICATION NO 10/085,100
				APPLICANT Enric AMOROS et al.	
				FILING DATE March 1, 2002	GROUP 3743


U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TP	AA	5,059,852	10/22/1991	Meury	310	339	
MB	AB	4,608,508	08/26/1986	Ohnishi	310	339	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
JP	AJ	JP 11-63498	03/05/1999	Japan w/Eng. Abstract			YES NO
JP	AK	JP 05-66014	03/19/1993	Japan w/Eng. Abstract			
	AL						
	AM						
	AN						
	AO						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	
	AR	

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4-21-04

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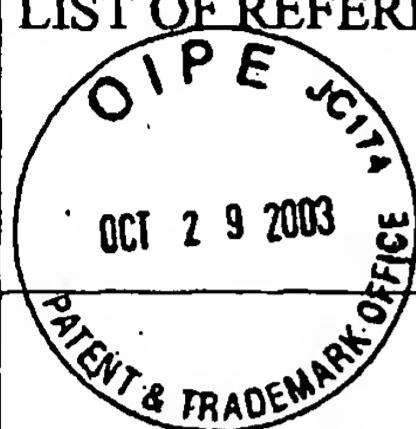
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Sheet 1 of 1

OCT 30 2003
Group 3700ATTY DOCKET NO.
618-1018APPLICATION NO.
10/085,100APPLICANT
Enric AMOROS et al.FILING DATE
March 1, 2002GROUP
3743

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)



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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JB	A01	3,829,737	8/13/1974	Johnsson	317	81	
	A02						
	A03						
	A04						
	A05						
	A06						
	A07						
	A08						
	A09						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	YES	NO
	B01								
	B02								
	B03								
	B04								
	B05								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	C01	
	C02	
	C03	

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ART UNIT 219

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<p style="text-align: center;">LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)</p> <p>1 MAY 09 2002 JC78</p>				ATTY. DOCKET NO.	APPLICATION NO.	
				618-1018	10/085,100	
				APPLICANT	Enric AMOROS et al.	
				FILING DATE	March 1, 2002	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MB	AA 6,116,892	09/2000	Yang	431	153	
	AB 6,106,277	08/2000	Xie	431	153	
	AC 6,102,689	08/2000	Man	431	153	
	AD 6,099,298	08/2000	Potskhishvili et al.	431	153	
	AE 6,099,297	08/2000	Chan	431	153	
	AF 6,099,296	08/2000	Wang	431	153	
	AG 6,095,796	08/2000	Sung	431	153	
	AH 6,095,795	08/2000	Potskhishvili et al.	431	153	
	AI 6,086,359	07/2000	Sher	431	153	
	AJ 6,086,358	07/2000	Potskhishvili et al.	431	153	
	AK 6,077,071	06/2000	Yeh	431	153	
	AL 6,077,070	06/2000	Doucet et al.	431	153	
	AM 6,077,069	06/2000	Fairbanks et al.	431	153	
	AN 6,074,198	06/2000	Rogelet	431	153	
	AO 6,065,958	05/2000	Adams et al.	431	153	
	AP 6,046,528	04/2000	LaForest et al.	310	339	
	AQ 6,045,354	04/2000	McDonough et al.	431	153	
	AR 6,010,328	01/2000	Sung	431	153	
	AS 5,980,239	11/1999	Doucet et al.	431	153	
	AT 5,927,962	07/1999	Amoros Nollas et al.	431	255	
	AU 5,854,530	12/1998	LaForest et al.	310	339	
	AV 5,788,474	08/1998	Chung et al.	431	153	
	AW 5,642,993	07/1997	McDonough et al.	431	153	
	AX 5,636,979	06/1997	McDonough et al.	431	153	
	AY 5,628,627	05/1997	Fairbanks et al.	431	153	
	AZ 5,584,682	12/1996	McDonough et al.	431	153	
	BA 5,487,657	01/1996	Fairbanks et al.	431	153	
	BB 5,495,719	07/1995	McDonough et al.	431	153	
<p style="text-align: center;">MARK U. 6085100</p> <p>EXAMINER: <i>PRIMARY EXAMINER</i> ART UNIT <i>210</i></p>				DATE CONSIDERED <i>4-21-04</i>		

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<p style="text-align: center;">LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)</p> <p style="text-align: center;">MAY 09 2002</p> <p style="text-align: center;">JC78</p>				ATTY. DOCKET NO.	APPLICATION NO.		
				618-1018	10/085,100		
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				Enric AMOROS et al.			
FILING DATE	GROUP						
March 1, 2002	3743						
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
MM	BC 5,417,571	05/1995	Kvalseth	431	153		
	BD 5,417,563	05/1995	Cirami	431	153		
	BE 5,262,697	11/1993	Meury	310	339		
	BF 5,240,408	08/1993	Kenjiro et al.	431	153		
	BG 5,215,458	06/1993	Cirami	431	277		
	BH 5,178,532	01/1993	Frigiere	431	254		
	BI 5,171,143	12/1992	Sohn	431	153		
	BJ 5,125,829	06/1992	McDonough et al.	431	255		
	BK 5,092,764	03/1992	McDonough et al.	431	277		
	BL 5,059,852	10/1991	Meury	310	339		
	BM 5,035,608	07/1991	Parren	431	153		
	BN 5,002,482	03/1991	Fairbanks et al.	431	277		
	BO 4,830,603	05/1989	Cirami	431	153		
	BP 4,758,152	07/1988	Kordecki	431	153		
	BQ 4,626,731	12/1986	Sadoya	310	339		
	BR 3,898,534	08/1975	Mohr	317	81		
	BS 3,883,289	05/1975	Fujioka	431	131		
	BT 3,817,691	06/1974	Tatsumi	431	255		
	BU 3,734,680	05/1973	Maruyama	431	132		
	BV 3,540,823	11/1970	Ebine et al.	431	255		
	BW 3,457,461	07/1969	Steinke et al.	317	81		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
MM	BX 6-249438	09/1994	Japan			X	Abs
MM	BY 60-89625	05/1985	Japan			X	Abs
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
BZ							
EXAMINER	<p style="text-align: center;">MARK U. BUDDY PRIMARY EXAMINER</p>			DATE CONSIDERED	<p style="text-align: center;">4-21-04</p>		
APT. UNIT 209							
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